捷多邦,专业PCB打样**\$N54州C町125**出**\$N74**HCT125 QUADRUPLE BUS BUFFER GATES WITH 3-STATE OUTPUTS

SCLS069C - NOVEMBER 1988 - REVISED MAY 1997

- Inputs Are TTL-Voltage Compatible
- High-Current 3-State Outputs Drive Bus Lines or Buffer Memory Address Registers
- Package Options Include Plastic Small-Outline (D) and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

description

These bus buffer gates feature independent line drivers with 3-state outputs. Each output is disasbled when the associated output-enable (\overline{OE}) input is high.

The SN54HCT125 is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74HCT125 is characterized for operation from –40°C to 85°C.

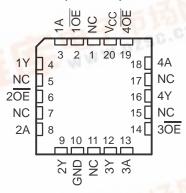
FUNCTION TABLE (each gate)

INPU	JTS	OUTPUT
OE	Α	Υ
L	Н	Н
L	L	L
Н	Χ	Z

SN54HCT125...J OR W PACKAGE SN74HCT125...D OR N PACKAGE (TOP VIEW)



SN54HCT125 . . . FK PACKAGE (TOP VIEW)



NC – No internal connection

logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, J, N, and W packages.



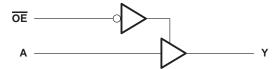
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SN54HCT125, SN74HCT125 QUADRUPLE BUS BUFFER GATES WITH 3-STATE OUTPUTS

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logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range[†]

Supply voltage range, V _{CC}	\dots –0.5 V to 7 V
Input clamp current, I _{IK} (V _I < 0 or V _I > V _{CC}) (see Note 1)	±20 mA
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{CC}) (see Note 1)	±20 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±35 mA
Continuous current through V _{CC} or GND	±70 mA
Package thermal impedance, θ _{JA} (see Note 2): D package	127°C/W
N package	78°C/W
Storage temperature range, T _{stq}	. -65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

recommended operating conditions

			SN	SN54HCT125			SN74HCT125		
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage		4.5	5	\$ 5.5	4.5	5	5.5	V
VIH	High-level input voltage	V _{CC} = 4.5 V to 5.5 V	2	Š	1/5	2			V
VIL	Low-level input voltage	V _{CC} = 4.5 V to 5.5 V	0	PA	0.8	0		0.8	V
VI	Input voltage		0	1	VCC	0		VCC	V
Vo	Output voltage		0	2	VCC	0		VCC	V
t _t	Input transition (rise and fall) time		00		500	0		500	ns
TA	Operating free-air temperature		-55		125	-40		85	°C



^{2.} The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		Voc	T _A = 25°C			SN54HCT125		SN74HCT125		UNIT
PARAMETER			vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
\/o	VI = VIH or VIL	I _{OH} = -20 μA	4.5 V	4.4	4.499		4.4		4.4		V
VOH	AI = AIH OI AIL	$I_{OH} = -6 \text{ mA}$	4.5 V	3.98	4.3		3.7		3.84		V
Voi	V _{OL} V _I = V _{IH} or V _{IL}	I _{OL} = 20 μA	4.5 V		0.001	0.1		0.1		0.1	V
VOL		I _{OL} = 6 mA	4.5 V		0.17	0.26		0.4		0.33	V
lį	$V_I = V_{CC}$ or 0		5.5 V		±0.1	±100		±1000		±1000	nA
loz	$V_O = V_{CC}$ or 0,	$V_I = V_{IH} \text{ or } V_{IL}$	5.5 V		±0.01	±0.5	4	±10		±5	μΑ
ICC	$V_I = V_{CC}$ or 0,	IO = 0	5.5 V			8	2	160		80	μΑ
ΔICC [†]	One input at 0.5 V of Other inputs at 0 or		5.5 V		1.4	2.4	Ody	3		2.9	mA
C _i			4.5 V to 5.5 V		3	10		10*		10	pF

^{*} On products compliant to MIL-PRF-38535, this parameter is not production tested.

switching characteristics over recommended operating free-air temperature range, $C_L = 50$ pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	FROM TO		T _A = 25°C			SN54HCT125	SN74HCT12	5 UNIT							
PARAMETER	(INPUT)	(OUTPUT)	VCC	MIN	TYP	MAX	MIN MAX	MIN MA	X							
+ .	А	Υ	4.5 V		15	26	39		33 ns							
'pd	^t pd A		5.5 V		12	23	3		30							
	t _{en}	V	4.5 V		18	28	42		35 ns							
^t en		OE	OE	OE	OE	OE	OE	OE	OE	'E '	5.5 V		15	25	38	
+		0-	lis OE	Y	4.5 V		15	26	ý 39		33 ns					
^t dis	OE	Ť	5.5 V		13	23	35		30							
4.	t Any	Any	4.5 V		8	15	22		19 ns							
^t t			Ariy	5.5 V		7	14	2		17						

switching characteristics over recommended operating free-air temperature range, C_L = 150 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	TO (OUTPUT)	Vaa	T _A = 25°C		SN54HCT125		SN74HCT125		UNIT	
PARAMETER	(INPUT)		Vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII
	А		4.5 V		19	36		58		46	20
^t pd	A	1	5.5 V		16	32		48		42	ns
		V	4.5 V		25	40	`	60		50	20
t _{en}	OE	Ť	5.5 V		21	35	2	53		43	ns
t _t		I Anv I	4.5 V		17	42	0	63		53	
			5.5 V		14	38	Q	57		48	ns

operating characteristics, T_A = 25°C

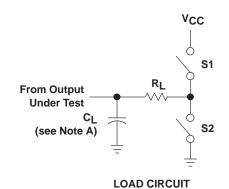
	PARAMETER	TEST CONDITIONS	TYP	UNIT
C _{pd} Po	ower dissipation capacitance	No load	35	pF



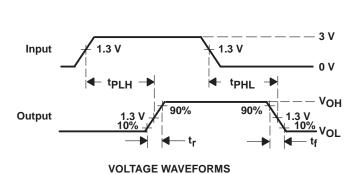
[†] This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V or V_{CC}.

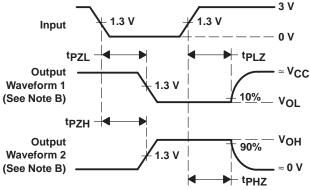
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PARAMETER MEASUREMENT INFORMATION



PARAI	PARAMETER		CL	S1	S2
ten		Open	Closed		
ten t	tPZL	1 K32	150 pF	Closed	Open
	tPHZ	1 kΩ	50 pF	Open	Closed
^t dis	tPLZ	1 K22	30 pr	Closed	Open
t _{pd} or	t _{pd} or t _t		50 pF or 150 pF	Open	Open





VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES FOR 3-STATE OUTPUTS

NOTES: A. C_I includes probe and jig capacitance.

PROPAGATION DELAY TIMES

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \Omega$, $t_r = 6$ ns, $t_f = 6$ ns.
- D. The outputs are measured one at a time with one input transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. tpzL and tpzH are the same as ten.
- G. t_{PLH} and t_{PHL} are the same as t_{pd}.

Figure 1. Load Circuit and Voltage Waveforms

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